

Notice of References Cited	Application/Control No. 10/725,514		Applicant(s)/Patent Under Reexamination HEENEY ET AL.	
	Examiner Shean C. Wu		Art Unit 1756	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0160230	08-2003	Ong et al.	257/20
*	B	US-6,770,904	08-2004	Ong et al.	257/40
	C	US-			
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	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	CAPLUS 2003: 568633
	V	CAPLUS 2003: 568634
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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